

## General Description

The WSK40200 is the highest performance SGT N-Channel MOSFET with extreme high cell density, which provide excellent  $R_{DS(ON)}$  and gate charge for most of the synchronous buck converter applications.

The WSK40200 meet the RoHS and Green Product requirement, 100%  $E_{AS}$  guaranteed with full function reliability approved.

## Features

- 100% UIS +  $R_g$  Tested.
- Reliable and Rugged
- Lead Free and Green Devices Available (RoHS Compliant)

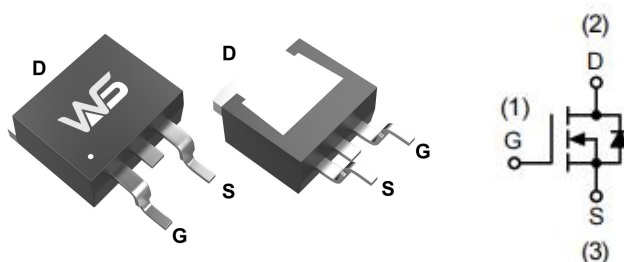
## Product Summary

$BV_{DSS}$	$R_{DS(ON)}$	$I_D$
40V	1.2m $\Omega$	280A

## Applications

- Power Management for Industrial DC/DC Converters
- Load switch
- Battery protection

## TO-263-2L Pin Configuration



## Absolute Maximum Ratings ( $T_A=25^{\circ}\text{C}$ , Unless Otherwise Noted)

Symbol	Parameter		Rating	Units
$V_{DS}$	Drain-Source Voltage		40	V
$V_{GS}$	Gate-Source Voltage		$\pm 20$	
$I_D$ <sup>7</sup>	Continuous Drain Current	$T_C=25^{\circ}\text{C}$	280	A
		$T_C=100^{\circ}\text{C}$	200	
$I_{DM}$ <sup>3</sup>	Pulse Drain Current		1120	W
$P_D$ <sup>2</sup>	Power Dissipation	$T_C=25^{\circ}\text{C}$	230	
$I_{AS}$ <sup>3</sup>	Single pulse Avalanche Current		70	A
$E_{AS}$ <sup>3</sup>	Single pulse Avalanche Energy	$L=0.3\text{mH}$	820	mJ
$T_{STG}$	Storage Temperature Range		-55 to 150	$^{\circ}\text{C}$
$T_J$	Operating Junction Temperature Range		-55 to 150	
$R_{\theta JA}$ <sup>1,4</sup>	Thermal Resistance-Junction to Ambient	$t \leq 10\text{s}$	20	$^{\circ}\text{C/W}$
		Steady State	60	
$R_{\theta JC}$	Thermal Resistance-Junction to Case		1.5	

**Electrical Characteristics ( $T_J=25^{\circ}\text{C}$ , Unless Otherwise Noted)**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Units
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V$ , $I_D=250\mu A$	40	48	---	V
$R_{DS(ON)}$	Static Drain-Source On-Resistance	$V_{GS}=10V$ , $I_D=20A$	---	1.2	1.5	m $\Omega$
		$V_{GS}=4.5V$ , $I_D=20A$	---	1.7	2.5	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}$ , $I_D=250\mu A$	1.0	1.8	2.5	V
$I_{DSS}$	Drain-Source Leakage Current	$V_{DS}=40V$ , $V_{GS}=0V$	---	---	1.0	$\mu A$
$I_{GSS}$	Gate-Source Leakage Current	$V_{DS}=0V$ , $V_{GS}=\pm 20V$	---	---	$\pm 100$	nA
$g_{fs}$	Forward Transconductance	$V_{DS}=5V$ , $I_D=20A$	---	23	---	S
$R_G$	Gate Resistance	$f=1.0\text{MHz}$	---	3.0	---	$\Omega$
$Q_g$	Total Gate Charge (10V)	$V_{DS}=20V$ , $V_{GS}=10V$ , $I_D=20A$	---	128	---	nC
$Q_{gs}$	Gate-Source Charge		---	36	---	
$Q_{gd}$	Gate-Drain Charge		---	26	---	
$T_{d(on)}$	Turn-On Delay Time	$V_{DS}=20V$ , $V_{GS}=10V$ , $R_L=1\Omega$ , $R_{GEN}=3\Omega$	---	23	---	ns
$T_r$	Rise Time		---	6.9	---	
$T_{d(off)}$	Turn-Off Delay Time		---	79	---	
$T_f$	Fall Time		---	27	---	
$C_{iss}$	Input Capacitance	$V_{DS}=20V$ , $V_{GS}=0V$ , $f=1.0\text{MHz}$	---	8300	---	pF
$C_{oss}$	Output Capacitance		---	1500	---	
$C_{rss}$	Reverse Transfer Capacitance		---	130	---	

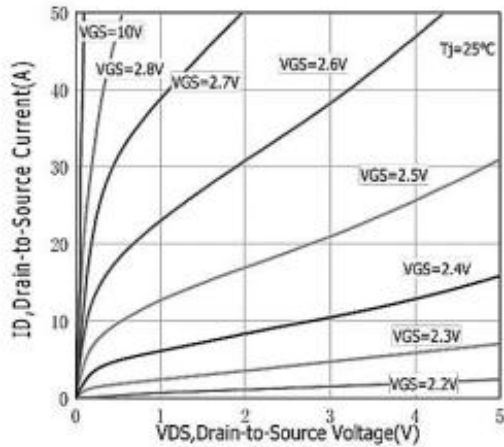
**Diode Characteristics**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Units
$I_S^7$	Continuous Source Current		---	---	300	A
$V_{SD}$	Diode Forward Voltage	$V_{GS}=0V$ , $I_S=1A$	---	0.7	1.2	V
$t_{rr}$	Reverse Recovery Time	$I_F=20A$ , $di/dt=500A/\mu s$	---	100	---	ns
$Q_{rr}$	Reverse Recovery Charge		---	163	---	nC

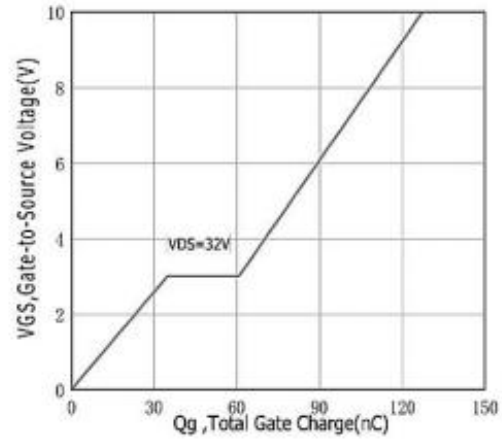
**Note:**

1. The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^{\circ}\text{C}$ . The Power dissipation  $P_{DSM}$  is based on  $R_{\theta JA} \leq 10s$  and the maximum allowed junction temperature of  $150^{\circ}\text{C}$ . The value in any given application depends on the user's specific board design.
2. The power dissipation  $P_D$  is based on  $T_{J(MAX)}=150^{\circ}\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
3. Single pulse width limited by junction temperature  $T_{J(MAX)}=150^{\circ}\text{C}$ .
4. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.
5. The static characteristics in Figures 1 to 6 are obtained using  $<300\mu s$  pulses, duty cycle 0.5% max.
6. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(MAX)}=150^{\circ}\text{C}$ . The SOA curve provides a single pulse rating.
7. The maximum current rating is package limited.
8. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^{\circ}\text{C}$ .
9. The maximum current rating is silicon limited

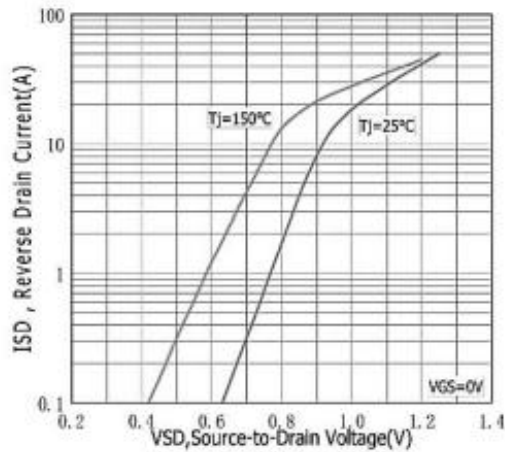
## Typical Characteristics



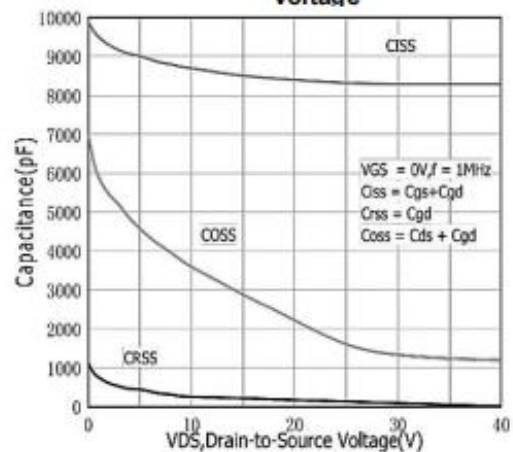
**Figure.1 Typical Output Characteristics**



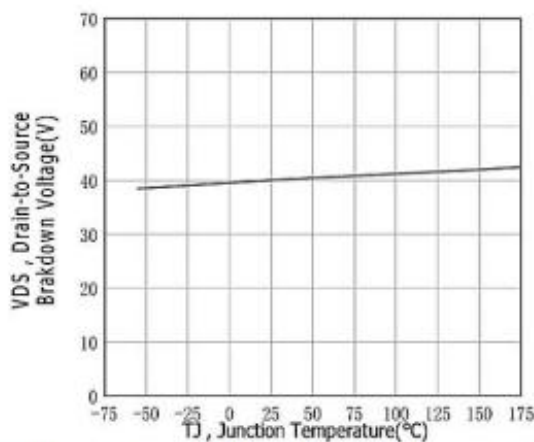
**Figure.2 Typical Gate Charge vs Gate to Source Voltage**



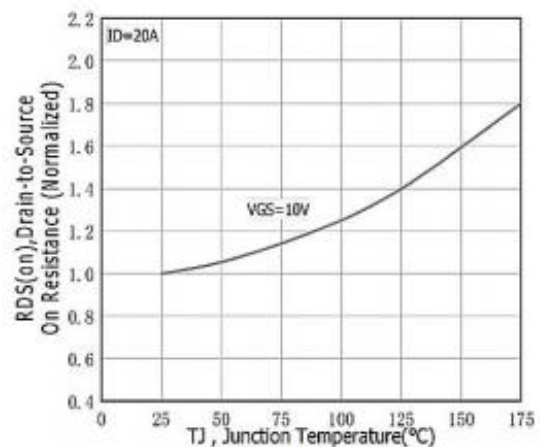
**Figure.3 Typical Body Diode Transfer Characteristics**



**Figure 4: Body Diode Characteristics**

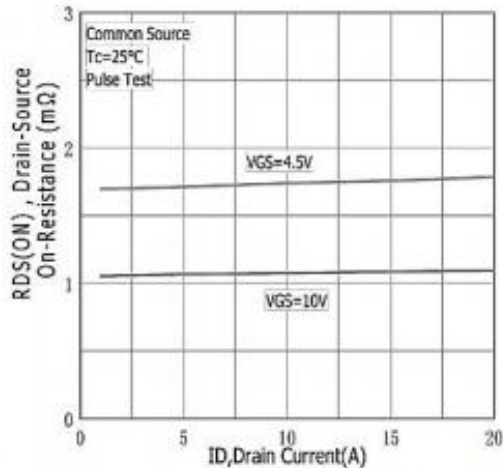


**Figure.5 Typical Breakdown Voltage vs Junction Temperature**

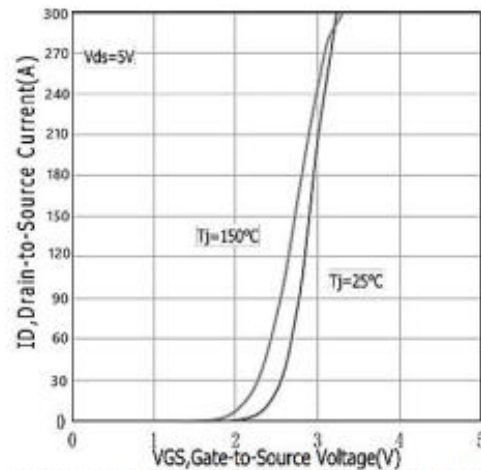


**Figure 6: Capacitance Characteristics**

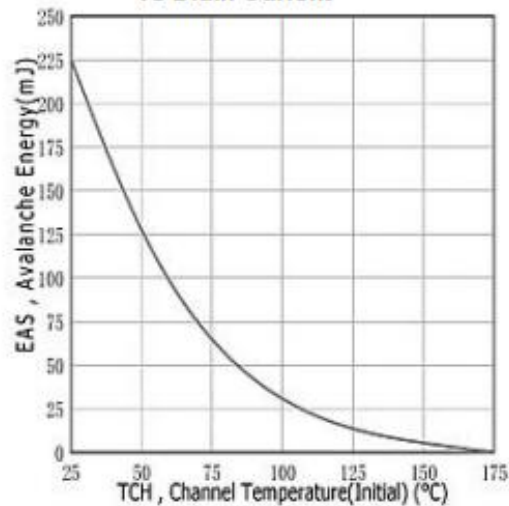
## Typical Characteristics (Cont.)



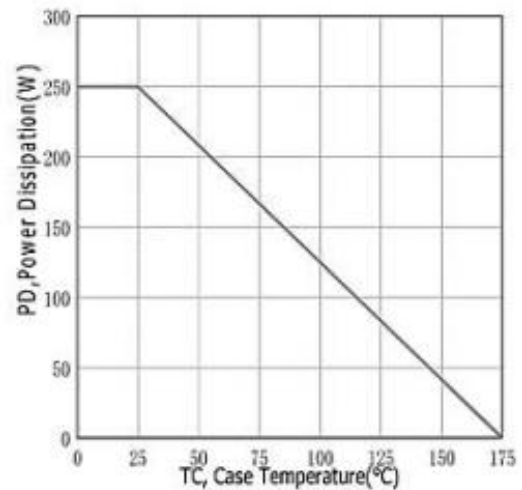
**Figure.7 Typical Drain to Source ON Resistance vs Drain Current**



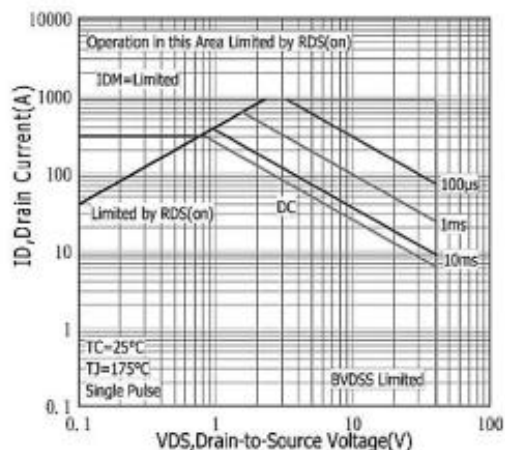
**Figure.10 Typical Transfer Characteristics**



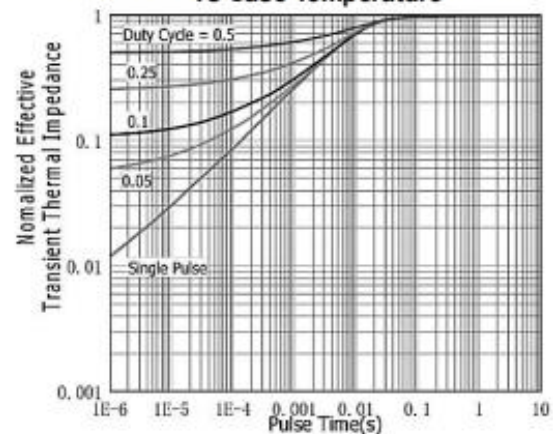
**Figure.9 Maximum EAS vs Channel Temperature**



**Figure.12 Maximum Power Dissipation vs Case Temperature**

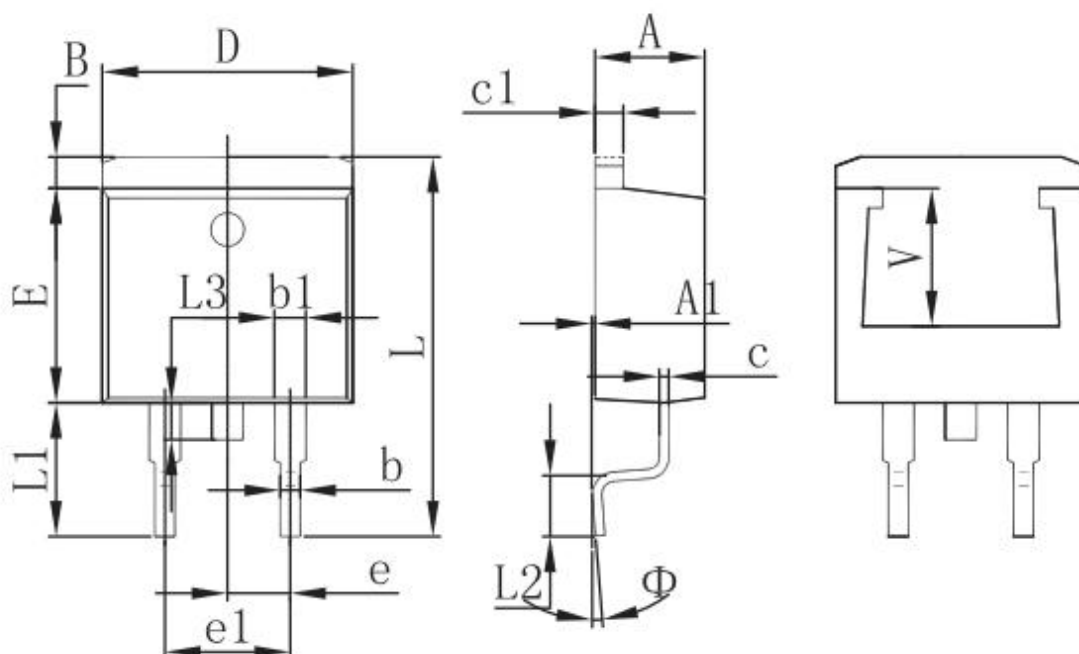


**Figure 11: Maximum Safe Operating Area**



**Figure.12: Maximum Effective Transient Thermal Impedance, Junction-to-Cas**

## Packaging information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	4.470	4.670	0.176	0.184
A1	0.000	0.150	0.000	0.006
B	1.120	1.420	0.044	0.056
b	0.710	0.910	0.028	0.036
b1	1.170	1.370	0.046	0.054
c	0.310	0.530	0.012	0.021
c1	1.170	1.370	0.046	0.054
D	10.010	10.310	0.394	0.406
E	8.500	8.900	0.335	0.350
e	2.540 TYP.		0.100 TYP.	
e1	4.980	5.180	0.196	0.204
L	14.940	15.500	0.588	0.610
L1	4.950	5.450	0.195	0.215
L2	2.340	2.740	0.092	0.108
L3	1.300	1.700	0.051	0.067
Φ	0°	8°	0°	8°
V	5.600 REF.		0.220REF.	



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